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# Insulated Gate Bipolar Transistor (Trench IGBT), 100 A



SOT-227

PRODUCT SUMMARY					
V <sub>CES</sub>	1200 V				
I <sub>C</sub> DC	100 A at 119 °C				
V <sub>CE(on)</sub> typical at 100 A, 25 °C	1.73 V				

#### **FEATURES**

 Trench IGBT technology with positive temperature coefficient



RoHS

- Square RBSOA
- 10 µs short circuit capability
- HEXFRED® antiparallel diodes with ultrasoft reverse recovery
- T<sub>J</sub> maximum = 150 °C
- Fully isolated package
- Very low internal inductance (≤ 5 nH typical)
- Industry standard outline
- UL approved file E78996
- Compliant to RoHS directive 2002/95/EC

#### **BENEFITS**

- Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Easy to assemble and parallel
- · Direct mounting to heatsink
- Plug-in compatible with other SOT-227 packages
- Speed 4 kHz to 30 kHz
- Very low V<sub>CE(on)</sub>
- Low EMI, requires less snubbing

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter voltage	V <sub>CES</sub>		1200	V	
Continuous collector current	I <sub>C</sub> <sup>(1)</sup>	T <sub>C</sub> = 25 °C	258		
Continuous collector current	IC ('')	T <sub>C</sub> = 80 °C	174		
Pulsed collector current	I <sub>CM</sub>		450		
Clamped inductive load current	I <sub>LM</sub>		450	А	
Diode continuous forward current	1	T <sub>C</sub> = 25 °C	50	]	
	IF	T <sub>C</sub> = 80 °C	34		
Peak diode forward current	I <sub>FSM</sub>		180		
Gate to emitter voltage	$V_{GE}$		± 20	V	
Dawer dissination ICDT	В	T <sub>C</sub> = 25 °C 893			
Power dissipation, IGBT	P <sub>D</sub>	T <sub>C</sub> = 119 °C	221	w	
De la contractiva de la de	В	T <sub>C</sub> = 25 °C	176	] vv	
Power dissipation, diode	P <sub>D</sub>	T <sub>C</sub> = 119 °C	44		
Isolation voltage	V <sub>ISOL</sub>	Any terminal to case, t = 1 min	2500	V	

#### Note

<sup>(1)</sup> Maximum continuous collector current must be limited to 100 A to do not exceed the maximum temperature of terminals

### GT100DA120U

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## Insulated Gate Bipolar Transistor (Trench IGBT), 100 A



<b>ELECTRICAL SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS	
Collector to emitter breakdown voltage	V <sub>BR(CES)</sub>	$V_{GE} = 0 \text{ V}, I_C = 250 \mu\text{A}$	1200	-	-		
Collector to emitter voltage	V	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 100 A	-	1.73	2.1	] <sub>v</sub>	
Collector to emitter voltage	V <sub>CE(on)</sub>	$V_{GE}$ = 15 V, $I_C$ = 100 A, $T_J$ = 125 °C	-	1.98	2.2	V	
Gate threshold voltage	V <sub>GE(th)</sub>	$V_{CE} = V_{GE}$ , $I_C = 7.5 \text{ mA}$	4.9	5.9	7.9		
Temperature coefficient of threshold voltage	$\Delta V_{GE(th)}/\Delta T_{J}$	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 1 mA (25 °C to 125 °C)	-	- 17.6	-	mV/°C	
Collector to emitter leakage current	1	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1200 V	-	0.6	100	μΑ	
Collector to emitter leakage current I <sub>CES</sub>		$V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$	-	0.6	10	mA	
Forward valtage drap	V	$I_F = 40 \text{ A}, V_{GE} = 0 \text{ V}$	-	2.81	3.3	V	
Forward voltage drop	$V_{FM}$	$I_F = 40 \text{ A}, V_{GE} = 0 \text{ V}, T_J = 125 \text{ °C}$	-	3.07	3.4	V	
Gate to emitter leakage current	I <sub>GES</sub>	$V_{GE} = \pm 20 \text{ V}$	-	-	± 200	nA	

SWITCHING CHARACTERI PARAMETER	SYMBOL	TEST CONDIT	MIN.	TYP.	MAX.	UNITS	
Turn-on switching loss	E <sub>on</sub>	$I_C = 100 \text{ A}, V_{CC} = 720 \text{ V},$		-	5.2	-	mJ
Turn-off switching loss	E <sub>off</sub>	$V_{GE} = 15 \text{ V}, R_g = 5 \Omega,$		-	7.1	-	
Total switching loss	E <sub>tot</sub>	$L = 500 \mu H, T_J = 25 °C$		-	12.3	-	
Turn-on switching loss	E <sub>on</sub>		Energy losses include tail and diode recovery (see fig. 20)	-	6.1	-	
Turn-off switching loss	E <sub>off</sub>			-	9.8	-	
Total switching loss	E <sub>tot</sub>	$I_C = 100 \text{ A}, V_{CC} = 720 \text{ V},$		-	15.9	-	
Turn-on delay time	t <sub>d(on)</sub>	$V_{GE} = 15 \text{ V}, R_g = 5 \Omega,$		-	350	-	ns ns
Rise time	t <sub>r</sub>	L = 500 μH, T <sub>J</sub> = 125 °C		-	75	-	
Turn-off delay time	t <sub>d(off)</sub>			-	374	-	
Fall time	t <sub>f</sub>			-	493	-	
Reverse bias safe operating area	RBSOA	$T_J$ = 150 °C, $I_C$ = 450 A, $R_g$ = 22 $\Omega$ , $V_{GE}$ = 15 V to 0 V, $V_{CC}$ = 900 V, $V_P$ = 1200 V, L = 500 $\mu$ H		Fullsquare			
Diode reverse recovery time	t <sub>rr</sub>	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s}, V_{rr} = 400 \text{ V}$		-	164	194	ns
Diode peak reverse current	I <sub>rr</sub>			-	12	15	Α
Diode recovery charge	Q <sub>rr</sub>			-	994	1455	nC
Diode reverse recovery time	t <sub>rr</sub>			-	230	273	ns
Diode peak reverse current	I <sub>rr</sub>	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s},$ $V_{rr} = 400 \text{ V}, T_{.l} = 125 \text{ °C}$		-	16.5	20	Α
Diode recovery charge	Q <sub>rr</sub>	V <sub>H</sub> = 100 V, V <sub>J</sub> = 120 °C	-	1864	2730	nC	
Short circuit safe operating area	SCSOA	$T_J = 150 ^{\circ}\text{C},  R_g = 22  \Omega,$ $V_{GE} = 15  \text{V to 0 V},  V_{CC} = 900  \text{V},$ $V_p = 1200  \text{V}$			10		μs



## Insulated Gate Bipolar Transistor (Trench IGBT), 100 A

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THERMAL AND MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNITS	
Maximum junction and storage temperature range	T <sub>J</sub> , T <sub>Stg</sub>	- 40	-	150	°C	
Junction to case	R <sub>thJC</sub>	-	-	0.14		
Diode		-	-	0.71	°C/W	
Case to sink per module	R <sub>thCS</sub>	-	0.1	-		
Mounting torque, 6-32 or M3 screw		-	-	1.3	Nm	
Weight		-	30	-	g	

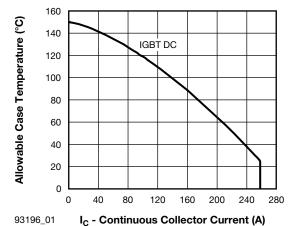


Fig. 1 - Maximum DC IGBT Collector Current vs. Case Temperature

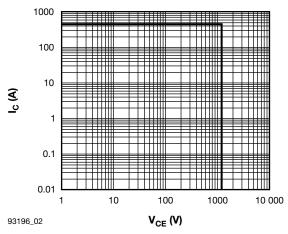


Fig. 2 - IGBT Reverse Bias SOA  $T_J = 150$  °C,  $V_{GE} = 15$  V

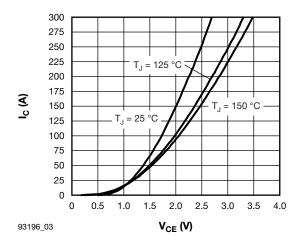


Fig. 3 - Typical IGBT Collector Current Characteristics  $V_{GE} = 15 \text{ V}$ 

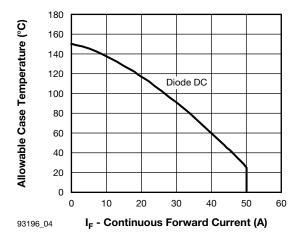


Fig. 4 - Maximum DC Forward Current vs. Case Temperature

## Insulated Gate Bipolar Transistor (Trench IGBT), 100 A



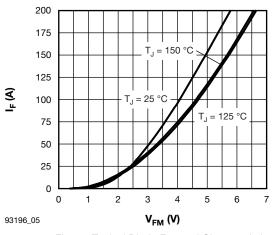


Fig. 5 - Typical Diode Forward Characteristics

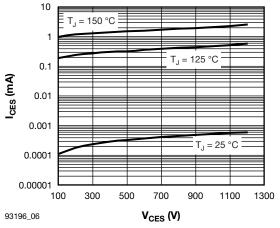


Fig. 6 - Typical IGBT Zero Gate Voltage Collector Current

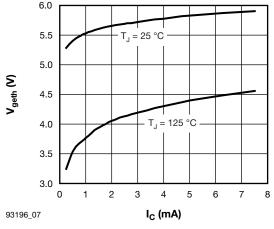


Fig. 7 - Typical IGBT Threshold Voltage

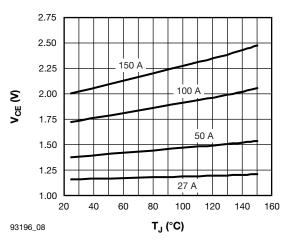


Fig. 8 - Typical IGBT Collector to Emitter Voltage vs. Junction Temperature,  $V_{GE} = 15 \text{ V}$ 

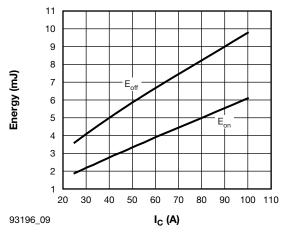


Fig. 9 - Typical IGBT Energy Loss vs. I<sub>C</sub>  $T_J$  = 125 °C, L = 500  $\mu$ H, V<sub>CC</sub> = 720 V,  $R_g$  = 5  $\Omega$ , V<sub>GE</sub> = 15 V

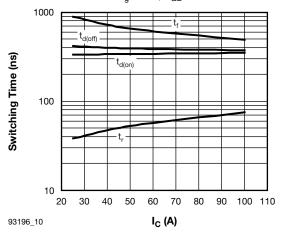


Fig. 10 - Typical IGBT Switching Time vs.  $I_C$   $T_J$  = 125 °C, L = 500  $\mu$ H,  $V_{CC}$  = 720 V,  $R_g$  = 5  $\Omega$ ,  $V_{GE}$  = 15 V





## Insulated Gate Bipolar Transistor (Trench IGBT), 100 A

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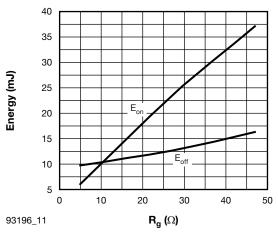


Fig. 11 - Typical IGBT Energy Loss vs.  $R_g$   $T_J$  = 125 °C,  $I_C$  = 100 A, L = 500  $\mu$ H,  $V_{CC}$  = 720 V,  $V_{GE}$  = 15 V

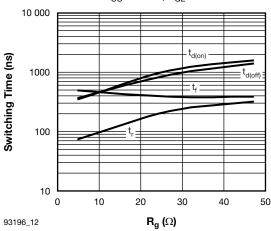


Fig. 12 - Typical IGBT Switching Time vs.  $R_g$   $T_J$  = 125 °C, L = 500  $\mu H,~V_{CC}$  = 720 V,  $I_C$  = 100 A,  $V_{GE}$  = 15 V

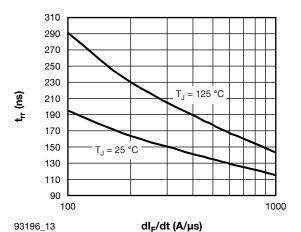


Fig. 13 - Typical  $t_{rr}$  Diode vs.  $dI_F/dt$  $V_{rr} = 400 \text{ V}$ ,  $I_F = 50 \text{ A}$ 

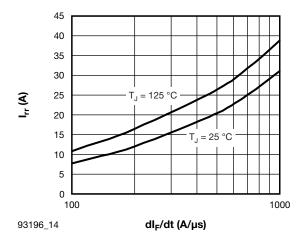


Fig. 14 - Typical I $_{\rm rr}$  Diode vs. dI $_{\rm F}$ /dt V $_{\rm rr}$  = 400 V, I $_{\rm F}$  = 50 A

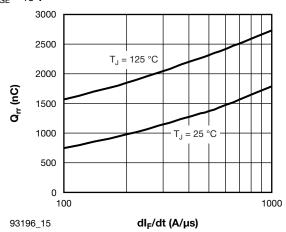


Fig. 15 - Typical  $Q_{rr}$  Diode vs.  $dI_F/dt$   $V_{rr} = 400 \text{ V}, I_F = 50 \text{ A}$ 

## Insulated Gate Bipolar Transistor (Trench IGBT), 100 A



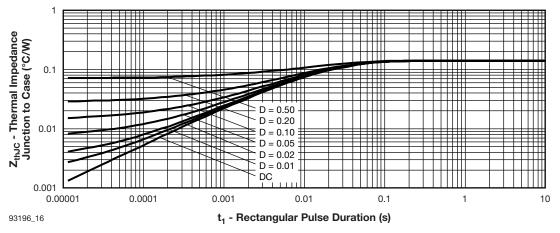


Fig. 16 - Maximum Thermal Impedance  $Z_{\text{thJC}}$  Characteristics (IGBT)

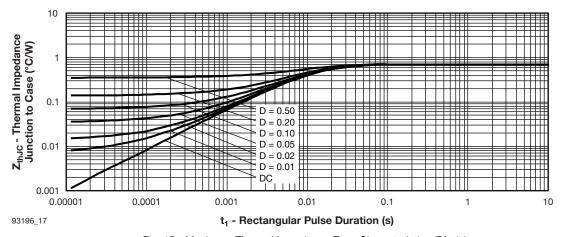
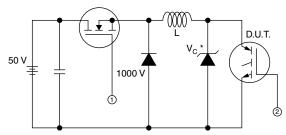


Fig. 17 - Maximum Thermal Impedance  $Z_{\text{thJC}}$  Characteristics (Diode)



#### Insulated Gate Bipolar Transistor (Trench IGBT), 100 A

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- \* Driver same type as D.U.T.;  $V_C$  = 80 % of  $V_{ce(max)}$  \* Note: Due to the 50 V power supply, pulse width and inductor will increase to obtain Id

Fig. 18a - Clamped Inductive Load Test Circuit

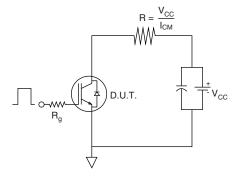


Fig. 18b - Pulsed Collector Current Test Circuit

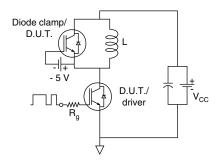


Fig. 19a - Switching Loss Test Circuit

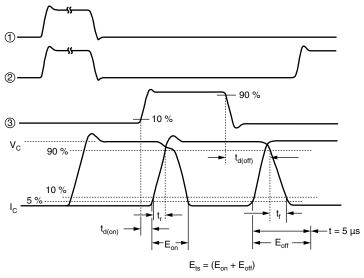


Fig. 19b - Switching Loss Waveforms Test Circuit

## Insulated Gate Bipolar Transistor (Trench IGBT), 100 A



#### **ORDERING INFORMATION TABLE**

**Device code** 

G	Т	100	D	Α	120	J
1	2	3	4	5	6	7

Insulated Gate Bipolar Transistor (IGBT)

T = Trench IGBT technology

3 - Current rating (100 = 100 A)

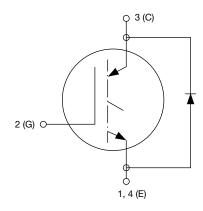
- Circuit configuration (D = Single switch with antiparallel diode)

5 - Package indicator (A = SOT-227)

- Voltage rating (120 = 1200 V)

Speed/type (U = Ultrafast)

#### **CIRCUIT CONFIGURATION**

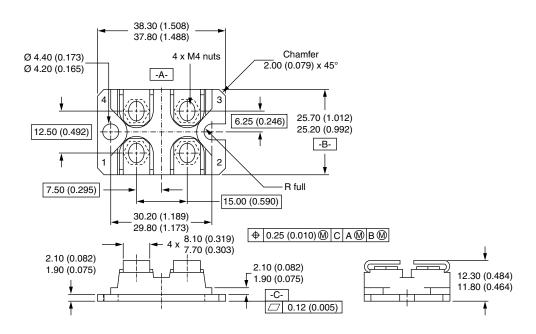


LINKS TO RELATED DOCUMENTS				
Dimensions <u>www.vishay.com/doc?95036</u>				
Packaging information <u>www.vishay.com/doc?95037</u>				



#### **SOT-227**

#### **DIMENSIONS** in millimeters (inches)



#### Notes

- Dimensioning and tolerancing per ANSI Y14.5M-1982
- · Controlling dimension: millimeter

Document Number: 95036 Revision: 28-Aug-07



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